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Form PTO 1449 U.S. DEPARTMENT (Modified) PATENT AND TRAD		OF COMMERCE EMARK OFFICE	ATTY DOCKET NO. 218206US3	\$	SERIAL NO.				
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LISTOF	KEFEF	CENCES CITED BY AFI	-LICANI	Shimpei MIURA, et al.	1		UE/VE		
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U.S. PATENT DOCUMENTS									
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FOREIGN PATENT DOCUMENTS									
		DOCUMENT DATE COUNTRY				TRANSLATION			
		NUMBER	DATE	COUNTRY		YES		NO	
RWH	AO	693 02 902	12/12/96	GERMANY				Х	
RWH	AP	100 60 726	06/27/2002	GERMANY				Х	
RWH	AQ	0 813 264	12/17/97	EUROPE					
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
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	AZ	Additional References sheet(s					et(s) attached		
Examiner	1-001 11000					Date Considered 2-23-05			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.									